Notice of References Cited Application/Control No. 10/005,083 Examiner Ahshik Kim Applicant(s)/Patent Under Reexamination SCHWANDNER, FRANK Page 1 of 1 U.S. PATENT DOCUMENTS

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	Α	US-5,483,827	01-1996	Kulka et al.	73/146.5
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	D	US-			
	Ε	US-			
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